

SKM100GB17E4



SEMITRANS® 2

IGBT4 Modules

SKM100GB17E4

Features

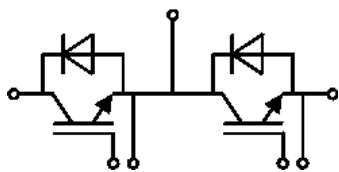
- IGBT4 = 4. generation medium fast trench IGBT (Infineon)
- CAL4 = Soft switching 4. Generation CAL-Diode
- Insulated copper baseplate using DBC Technology (Direct Copper Bonding)
- With integrated Gate resistor
- For switching frequencies up to 8kHz
- UL recognized, file no. E63532

Typical Applications*

- AC inverter drives
- UPS
- Electronic welders
- Wind power
- Public transport

Remarks

- Case temperature limited to $T_c = 125^\circ\text{C}$ max.
- Recommended $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for $T_j = 150^\circ\text{C}$



GB

Absolute Maximum Ratings				
Symbol	Conditions		Values	Unit
IGBT				
V _{CES}	T _j = 25 °C		1700	V
I _C	T _j = 175 °C	T _c = 25 °C	164	A
		T _c = 80 °C	127	A
I _{Cnom}			100	A
I _{CRM}	I _{CRM} = 3xI _{Cnom}		300	A
V _{GES}			-20 ... 20	V
t _{psc}	V _{CC} = 1000 V V _{GE} ≤ 15 V V _{CES} ≤ 1700 V	T _j = 150 °C	10	μs
T _j			-40 ... 175	°C
Inverse diode				
I _F	T _j = 175 °C	T _c = 25 °C	113	A
		T _c = 80 °C	83	A
I _{Fnom}			100	A
I _{FRM}	I _{FRM} = 2xI _{Fnom}		200	A
I _{FSM}	t _p = 10 ms, sin 180°, T _j = 25 °C		650	A
T _j			-40 ... 175	°C
Module				
I _{t(RMS)}			200	A
T _{stg}			-40 ... 125	°C
V _{isol}	AC sinus 50 Hz, t = 1 min		4000	V

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
IGBT						
V _{CE(sat)}	I _C = 100 A	T _j = 25 °C		1.90	2.20	V
	V _{GE} = 15 V chiplevel	T _j = 150 °C		2.30	2.60	V
V _{CE0}	chiplevel	T _j = 25 °C		0.8	0.9	V
		T _j = 150 °C		0.7	0.8	V
r _{CE}	V _{GE} = 15 V chiplevel	T _j = 25 °C		11	13	mΩ
		T _j = 150 °C		16	18	mΩ
V _{GE(th)}	V _{GE} =V _{CE} , I _C = 4 mA		5.2	5.8	6.4	V
I _{CES}	V _{GE} = 0 V	T _j = 25 °C			1	mA
	V _{CE} = 1700 V	T _j = 150 °C				mA
C _{ies}	V _{CE} = 25 V V _{GE} = 0 V	f = 1 MHz		9		nF
C _{oes}		f = 1 MHz		0.34		nF
C _{res}		f = 1 MHz		0.29		nF
Q _G	V _{GE} = - 8 V...+ 15 V			800		nC
R _{Gint}	T _j = 25 °C			7.5		Ω
t _{d(on)}	V _{CC} = 1200 V	T _j = 150 °C		234		ns
t _r	I _C = 100 A		T _j = 150 °C		39	
E _{on}	V _{GE} = +15/-15 V	T _j = 150 °C		43		mJ
t _{d(off)}	R _{G on} = 2 Ω	T _j = 150 °C		657		ns
t _f	R _{G off} = 2 Ω	T _j = 150 °C		136		ns
E _{off}	di/dt _{on} = 2540 A/μs	T _j = 150 °C				
	di/dt _{off} = 610 A/μs					
	du/dt = 5430 V/μs			39		mJ
R _{th(j-c)}	per IGBT				0.234	K/W



SEMITRANS® 2

IGBT4 Modules

SKM100GB17E4

Features

- IGBT4 = 4. generation medium fast trench IGBT (Infineon)
- CAL4 = Soft switching 4. Generation CAL-Diode
- Insulated copper baseplate using DBC Technology (Direct Copper Bonding)
- With integrated Gate resistor
- For switching frequencies up to 8kHz
- UL recognized, file no. E63532

Typical Applications*

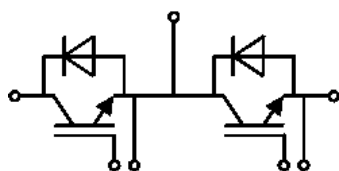
- AC inverter drives
- UPS
- Electronic welders
- Wind power
- Public transport

Remarks

- Case temperature limited to $T_c = 125^\circ\text{C}$ max.
- Recommended $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for $T_j = 150^\circ\text{C}$

Characteristics

Symbol	Conditions		min.	typ.	max.	Unit
Inverse diode						
$V_F = V_{EC}$	$I_F = 100\text{ A}$ $V_{GE} = 0\text{ V}$ chipllevel	$T_j = 25^\circ\text{C}$		2.00	2.40	V
		$T_j = 150^\circ\text{C}$		2.15	2.57	V
V_{F0}	chipllevel	$T_j = 25^\circ\text{C}$		1.32	1.56	V
		$T_j = 150^\circ\text{C}$		1.08	1.22	V
r_F	chipllevel	$T_j = 25^\circ\text{C}$		6.8	8.4	mΩ
		$T_j = 150^\circ\text{C}$		11	14	mΩ
I_{RRM}	$I_F = 100\text{ A}$	$T_j = 150^\circ\text{C}$		86		A
Q_{rr}	$di/dt_{off} = 2360\text{ A}/\mu\text{s}$ $V_{GE} = -15\text{ V}$	$T_j = 150^\circ\text{C}$		34		μC
E_{rr}	$V_{CC} = 1200\text{ V}$	$T_j = 150^\circ\text{C}$		26		mJ
$R_{th(j-c)}$	per diode				0.504	K/W
Module						
L_{CE}				30		nH
$R_{CC'+EE'}$	terminal-chip	$T_c = 25^\circ\text{C}$		0.65		mΩ
		$T_c = 125^\circ\text{C}$		1.09		mΩ
$R_{th(c-s)}$	per module			0.04	0.05	K/W
M_s	to heat sink M6		3		5	Nm
M_t		to terminals M5	2.5		5	Nm
						Nm
w					160	g



GB

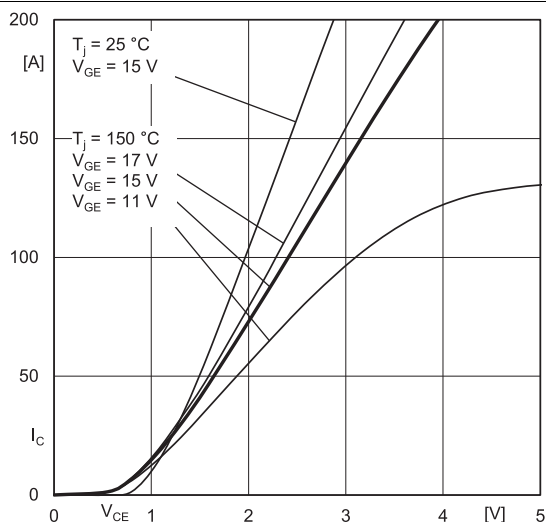


Fig. 1: Typ. output characteristic, inclusive $R_{CC'} + EE'$

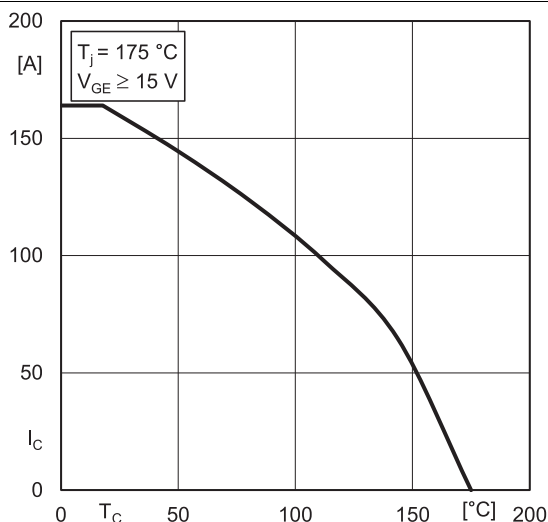


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

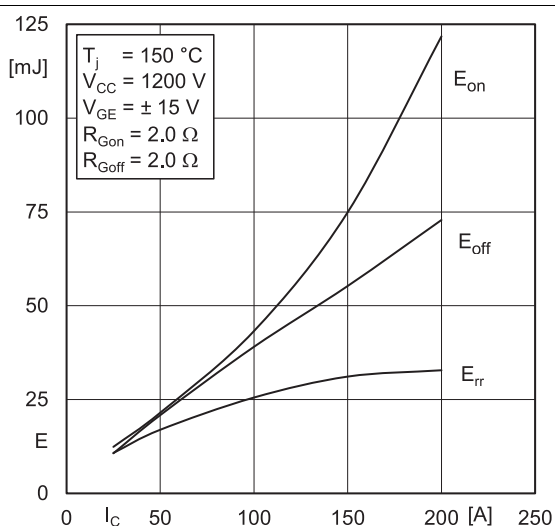


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

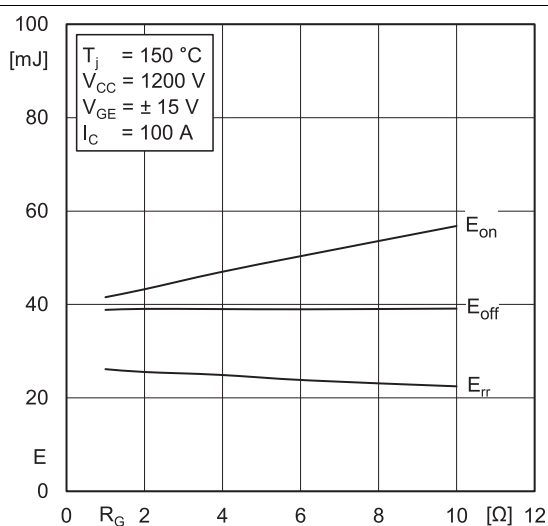


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

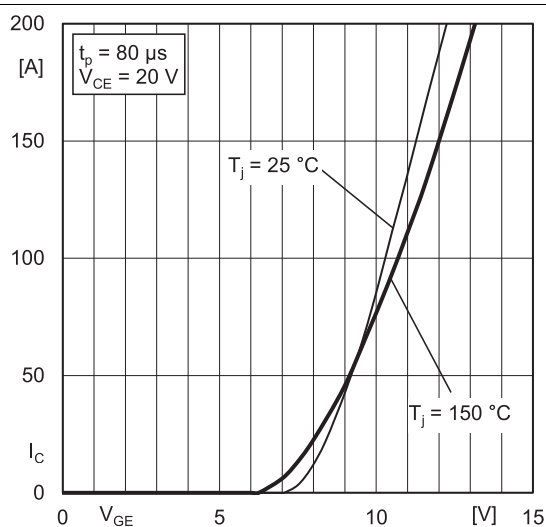


Fig. 5: Typ. transfer characteristic

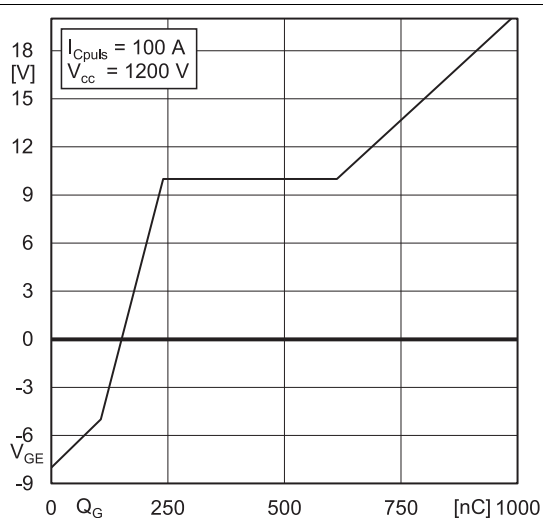


Fig. 6: Typ. gate charge characteristic

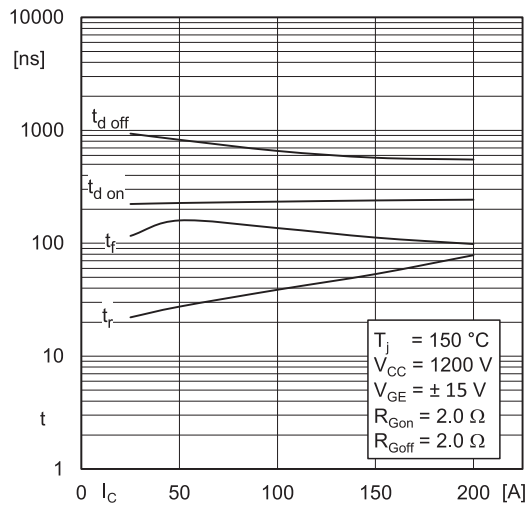


Fig. 7: Typ. switching times vs. I_C

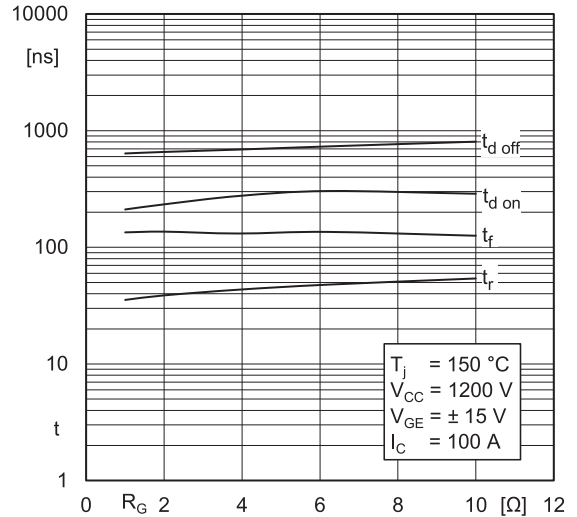


Fig. 8: Typ. switching times vs. gate resistor R_G

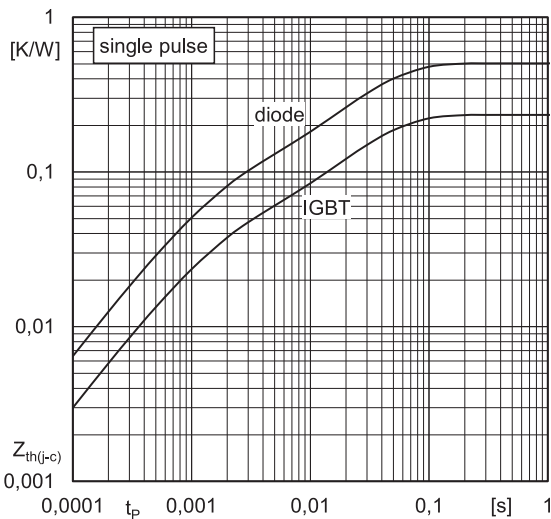


Fig. 9: Transient thermal impedance

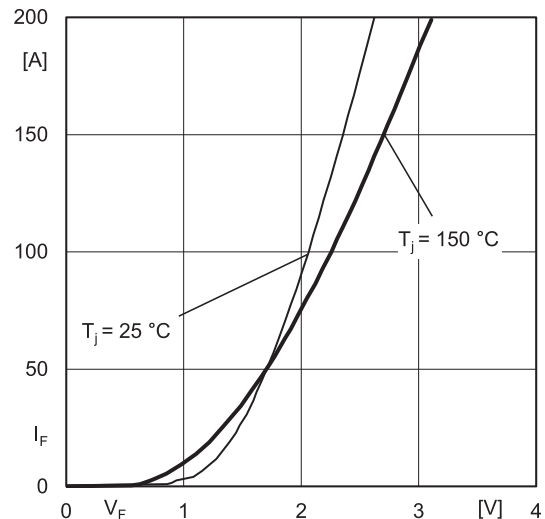


Fig. 10: Typ. CAL diode forward charact., incl. $R_{CC'+EE'}$

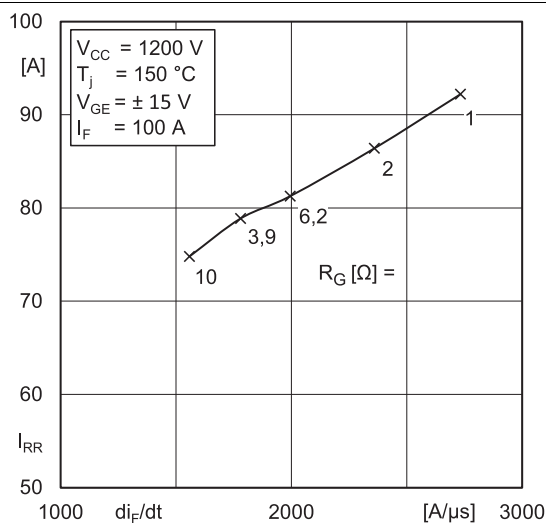


Fig. 11: CAL diode peak reverse recovery current

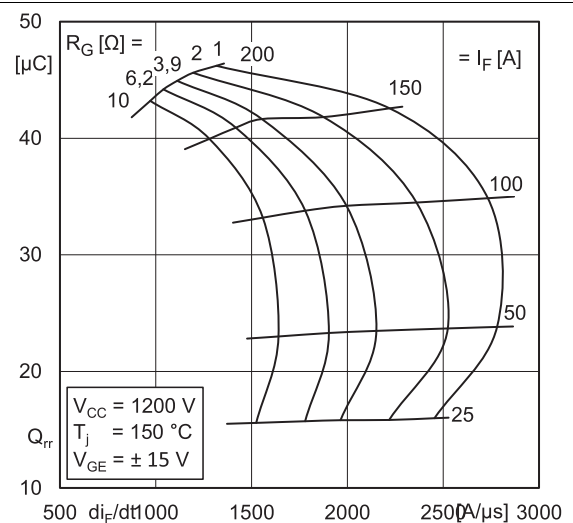
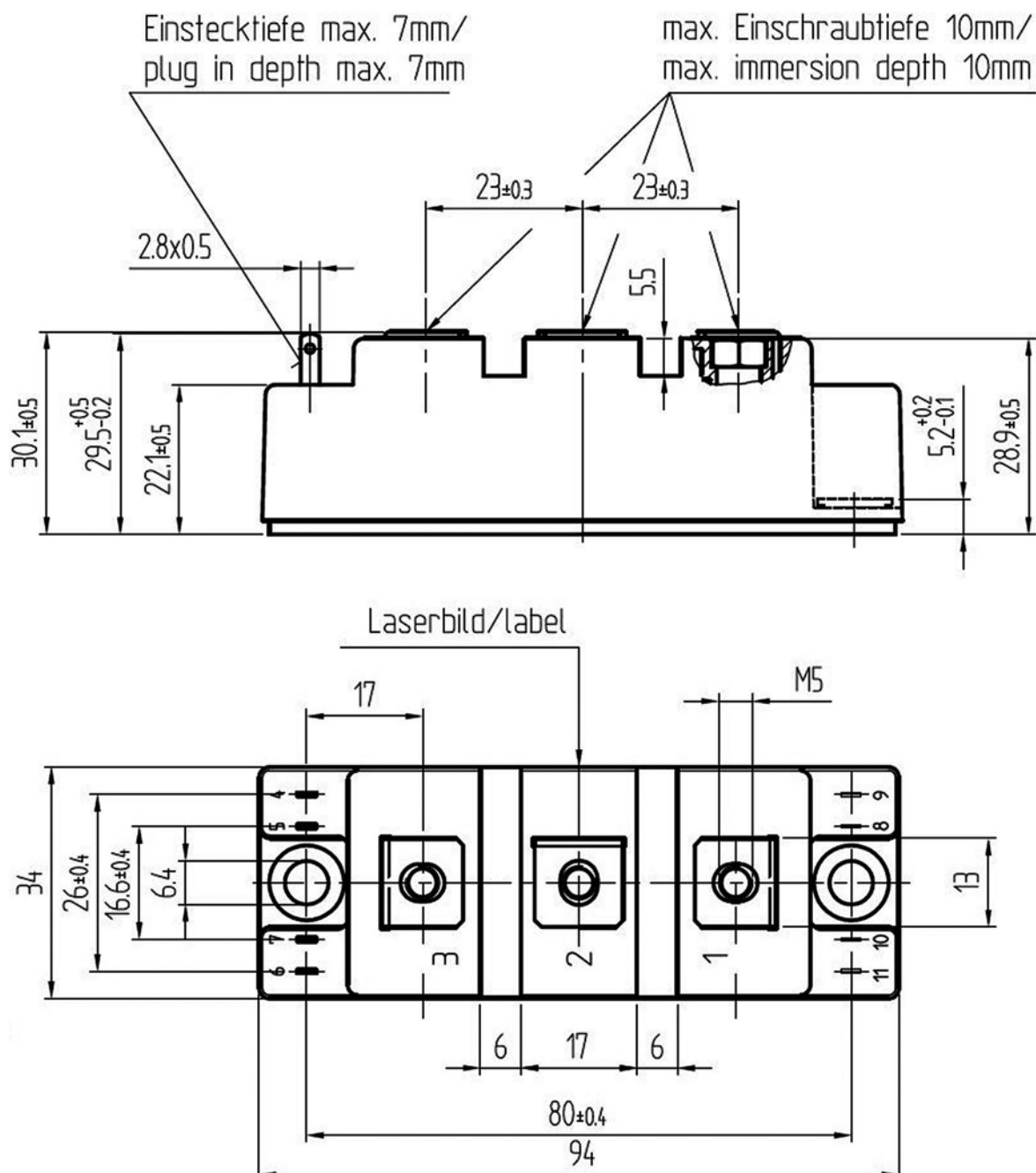
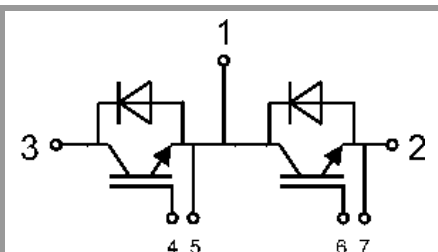


Fig. 12: Typ. CAL diode peak reverse recovery charge



SEMITRANS 2



GB

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.